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(E2 Emulator, CS+)

Introduction

This application note introduces how to measure CAN bus reception processing times by combining the E2 emulator and the integrated development environment (CS+ for CC), and notes on usage.

This solution is used to improve the problems related to the speed performance of the CAN bus communication applications. You can easily measure the time from detecting a specific CAN frame on the bus up to executing a desired code in a program. The timing of a CAN frame and desired program processing can be shown on the same time base and the time taken for debugging to identify the cause can be shortened.

Target Device

RH850 Family

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Configuration of Manuals

The documents related to the CAN communication time measurement solution, which is an extended function of the E2, consist of the following.

- E2 Emulator User's Manual
- E1/E20 Emulator, E2 Emulator Additional Document for User's Manual
- User's manual and help for the emulator debugger
- Application Note for the CAN Communication Time Measurement Solution (E2 Emulator, CS+) (this document)
- (1) E2 Emulator User's Manual (document No.: R20UT3538EJxxxx)
 - The E2 emulator user's manual has the following contents:
 - Components of the E2 emulator
 - Hardware specifications of the E2 emulator
 - Connection to the E2 emulator and the host machine and user system
- (2) E1/E20 Emulator, E2 Emulator Additional Document for User's Manual The E1/E20 Emulator, E2 Emulator Additional Document for User's Manual describes the functions of the debugger and also provides information and notes which depend on each microcontroller.
- (3) User's manual and help for the emulator debugger

The user's manual and help for the emulator debugger describe the functions of the E1/E20/E2 emulator debugger and the operating instructions.

Refer to the following.

• CS+ Integrated Development Environment User's Manual: RH850 Debug Tool

The CAN communication time measurement solution can also be referred to from online help for the CS+.

- <u>Online help for the CS+</u>
- (4) Application Note for the CAN Communication Time Measurement Solution (E2 Emulator, CS+) (this document) The Application Note for the CAN Communication Time Measurement Solution (E2 Emulator, CS+) covers the setup method, usages, and notes on measuring CAN bus communication processing times.



Terminology

Some specific words used in this user's manual are defined below.

Integrated development environment

This tool provides powerful support for the development of embedded applications for Renesas microcomputers. It has an emulator debugger function allowing the emulator to be controlled from the host machine via an interface. Furthermore, it permits a range of operations from editing a project to building and debugging it to be performed within the same application. In addition, it supports version management.

Emulator debugger

This means a software tool that is started up from the integrated development environment, and controls the emulator and enables debugging.

Host machine

This means a personal computer used to control the emulator.

Target device

This means the device to be debugged.

User system

This means a user's application system in which the device to be debugged is used.

User program

This means the application program to be debugged.

User system interface

This means an interface that connects the target device to the E2 emulator.

Extended function of the E2

This means an extended function which is provided with the E2 emulator.

E2 expansion interface

This means the interface required for extended functions of the E2 emulator.

E2 storage

This means the memory which is mounted on the E2 emulator and used for storing data regarding extended functions of the E2 emulator.



1. Overview

The CAN communication time measurement solution, which is provided by the E2 emulator and integrated development environment (CS+ for CC), is used to easily measure the time from data reception to a desired software processing in a system using CAN bus communication, such as that shown in Figure 1-1. Since it is possible to make a setting to halt program execution when the time from data reception to processing end exceeds the design value, viewing trace data or the history of CAN bus communication after program stop will contribute in determining the cause at an early stage.

The characteristics of the CAN communication time measurement solution are given on the following pages.



Figure 1-1 Example of a System Using CAN Bus Communication



1.1 Measuring the Time from Receiving a Specific Frame of CAN Bus Communication to Performing a Specific Processing

The first characteristic is automation of measurement as shown in Figure 1-3 which will reduce the working time. Up to now, measurement was repeatedly done by hand as shown in Figure 1-2. The working time can also be reduced by automating the embedding of debugging code which has been performed manually at the measurement points of the program. Furthermore, the timing of running the program can be measured by embedding debugging code even if the user system has no port pins available for debugging.



Figure 1-2 Conventional Method



Figure 1-3 Measuring CAN Bus Reception Processing Times



1.2 Recording CAN Frames and Operation Timing of Software in a Log on the Same Time Base

The second characteristic is confirmation of CAN frames and the timing of running the program on the same time base by using only the E2 emulator, as shown in Figure 1-4. The log can be useful in identifying the cause in a case where the time from receiving a CAN frame to the processing being completed exceeds the design value. Figure 1-5 shows an example of the procedure for investigating the cause.



Figure 1-4 Log Acquisition of CAN Frames and Program Execution Timing



Figure 1-5 Example of Procedure for Investigating the Cause



2. Functional Description

This section introduces the specifications and performance of the CAN communication time measurement solution.

2.1 List of Functional Specifications

The functional specifications are listed in Table 2-1 and Table 2-2.

Item	Specification			
Measurement method Measurement target	Conne extern interfa • Measu The ti given is also code a insertu * A so	o possible) reaches the RH850, at the specified address (at whic ed*) is executed. oftware trace instruction is used ollowing combinations are possib) device to the E2 expansion neasured. One point is when a and data, for which masking of bits and the other point is when the th a debugging instruction is	
	No.	Start Condition for Time Measurement	End Condition for Time Measurement	
	1	Arrival of a given CAN bus communication signal	Execution of a given software trace instruction	
	2	Arrival of a given CAN bus communication signal	External trigger input	
	3	External trigger input	Execution of a given software trace instruction	
	4	External trigger input	External trigger input	
Measurement point	Measurement is possible through up to two CAN bus reception data input pins simultaneously.		vo CAN bus reception data input	
Types of time measurement	Maximun	n time, minimum time, average t	ime, pass count	
Timeout detection	A timeou	A timeout of the specified time can be detected.		
Action on timeout detection		A break, stopping of internal tracing, or external trigger output can be selected as the action on timeout detection.		
Recording capacity	 In full Numb timing In full Numb instruct 	 selected as the action on timeout detection. 8 Mbytes (E2 storage) In full stop mode for detection of only CAN frames Number of recorded data items: 348,000 frames (dependent on the timing when CAN bus communication takes place) 		



Item	Specification
Recording mode The following three recording modes are supported.	
	 Overwrite the recording memory and continue after the recording memory is full
	 Stop recording after the recording memory is full
	 Stop the program after the recording memory is full
Types of recorded data	Timestamp + software trace data (DBTAG number)
	Timestamp + CAN frame (ID, DATA, DLC, ACK)
CAN bus communication Conforms to CAN 2.0B.	
	1M bps, 500K bps, 250K bps, and 125K bps are supported as the
	communication baud rate.
Sampling frequency	120 [MHz]
Timestamp	Count source: 8.33 [ns] (120 [MHz])
Storage format of recorded data	The recorded data are saved in the CSV format or Microsoft Office Excel book (*.xls) format.

Table 2-2 List of Functional Specifications (2/2)



2.2 Timing for Measuring CAN Bus Reception Processing Times

The timing for measuring the section time (td) is described for each measurement item.

For the measurement error of each measurement item, see "5.6 Notes on Time Measurement Function".





Figure 2-1 Timing for Measuring the Time of Section td (CAN_EOF_Sample - DBTAG)

(2) Timing for measuring the section time from receiving CAN frame to trigger input



Figure 2-2 Timing for Measuring the Time of Section td (CAN_EOF_Sample - TRGIN)



(3) Timing for measuring the section time from trigger input to software tracing (DBTAG)



Figure 2-3 Timing for Measuring the Time of Section td (TRGIN – DBTAG)

(4) Timing for measuring the section time from trigger input to trigger input



Figure 2-4 Timing for Measuring the Time of Section td (TRGIN – TRGIN)



2.3 Timestamp Specifications

- (1) The timestamp starts from the data that was recorded first.
- (2) The timing for recording the timestamp is as shown in the figure below.



Figure 2-5 Timing for Recording the Timestamp (CAN Frame)



Figure 2-6 Timing for Recording the Timestamp (DBTAG Instruction)



3. Setup

The setup procedure is given in Figure 3-1.



Figure 3-1 Setup Procedure



3.1 Installing the Emulator Debugger

If you intend to use the E2 emulator, download and install the latest integrated development environment from the following Web site.

https://www.renesas.com/e2-download

3.2 Setting the Hardware Environment



Figure 3-2 System Configuration Example



(1) Connecting the E2 emulator to the user system

Connect the E2 emulator to the user system with the user-system interface cable.

Set the switch on the 20-pin (1.27-mm pin spacing) to 14-pin (2.54-mm pin spacing) connector conversion adapter to position "1".



Figure 3-3 Connecting the User-System Interface Cable to the 14-Pin Connector



- (2) Connecting to the E2 expansion interface
- 1. Connect the expansion interface (GND: pin 13) of the E2 emulator to the GND of the user system using the attached test lead.
- Connect the expansion interface (CAN monitoring RX pins: pin 4 for ch0, pin 8 for ch1) of the E2 emulator to the RH850 CAN receive data input pin of the user system using the attached test lead. For pin arrangement of the E2 expansion interface, see Figure 3-4 and Table 3-1.



Figure 3-4 Pin Arrangement of E2 Expansion Interface

Table 3-1	Pins of E2 Expansion Interface
-----------	--------------------------------

Pin No.	Input/Output	Description
1	-	-
2	-	-
3	-	-
4	Input	CAN monitoring RX (ch. 0)
5	-	-
6	-	-
7	-	-
8	Input	CAN monitoring RX (ch. 1)
9	Output	External trigger output (ch. 0)
10	Output	External trigger output (ch. 1)
11	Input	External trigger input (ch. 0)
12	Input	External trigger input (ch. 1)
13	-	GND
14	Output	A pin for output of the power-supply voltage for the E2 expansion interface (1.8 V to 5.0 V)



3.3 Turning on the E2 Emulator and User System

- 1. Connect the A plug of the USB interface cable to the USB interface connector of the host machine.
- 2. Connect the mini-B plug of the USB interface cable to the USB interface connector of the E2 emulator. The power of the E2 emulator is turned on by connecting the emulator to the host machine with a USB interface cable.
- 3. Turn on the user system.



4. Using the Emulator Debugger

4.1 Setup when Starting the Emulator Debugger

(1) Selecting the emulator

Right-click on 🐳 on the Project Tree panel and select an emulator as shown in the figure below.

Project Tree			
2 🕜 🤮 😰			
🖃 🕂 can (Project)*			
R7F701007xAFP (Micro	ocontroller)		
CC-RH (Build Tool)			
	oua Tool)		
	Using Debug Tool 🔹 🕨		RH850 E2
iai∭ File	Property		RH850 E1(LPD)
L			RH850 E20(LPD)
		~	RH850 Simulator

Figure 4-1 Starting the Emulator Debugger (Selection of Emulator)



- (2) Making settings for connection
- 1. Right-click on 👻 on the Project Tree panel and select [Property].

Project Tree
2 @ 2 2
□····································

Figure 4-2 Starting the Emulator Debugger (Selection of Property)

2. Make a setting for [E2 Expansion Interface] in the [Connection Settings] tabbed page on the Property panel of [RH850 E2], as shown in the figure below.

4 E2 Expansion Interface	
Use the E2 expansion interface	Use the power supplied from the target
	No use
	Use the power supplied from the target

Figure 4-3 Starting the Emulator Debugger (Usage of E2 Expansion Interface)

- 3. Make a setting for software tracing in the [Connection Settings] tabbed page on the Property panel of [RH850 E2], as shown in the figure below.
 - a) Enable software tracing through LPD output.

	Output the software trace from the LPD	Yes	•
--	--	-----	---

Figure 4-4 Starting the Emulator Debugger (Software Trace a)

b) For a multicore MCU, select the core on which you wish to execute the debugging instruction (DBTAG instruction) that was set as a measurement range end condition.
 This setting is unnecessary for single-core MCUs. (The following menu will not appear.)

Target when outputting the software trace from the LPD	CPU1
	CPU1
	CPU2

Figure 4-5 Starting the Emulator Debugger (Software Trace b)

c) Enable output of the DBTAG instruction.

Figure 4-6	Starting the Emulator Debugger (Software Trace c)
Output the DBTAG	Yes



- (3) Connecting the emulator debugger
- 1. Select [Build & Download] from the [Debug] menu to start the emulator debugger and download data.

Debug Solutions Download Download P6 Rebuild & Download	Deb	oug Tool Window Help	
Build & Download F6		Debug Solutions	•
	D.	Download	
Rebuild & Download	6	Build & Download	F6
	6	Rebuild & Download	
Connect to Debug Tool	00	Connect to Debug Tool	

Figure 4-7 Starting the Emulator Debugger (Connection of Emulator Debugger)



4.2 Setting Measurement Conditions and Starting Measurement

(1) Setting a measurement range end point (inserting the DBTAG instruction for software tracing)

Use either one of the two methods shown below.

- Automatically inserting a debugging instruction (DBTAG) from the Editor panel of the emulator debugger
- Writing a debugging instruction (DBTAG) to the source code

• <u>Automatically inserting a debugging instruction (DBTAG) from the Editor panel</u> Move the cursor in the Editor panel to a point in the source code at which you want to stop measuring the section time. Right-click on the point and select the DBTAG instruction to be inserted, as shown in Figure 4-8.

Set Measuring CAN Bus Reception Processing Times	• 🦉	Set DBTAG insertion point	Insert DBTAG(0x21)
Save Source Mixed Data As	×	Delete insertion point for DBTAG	Insert DBTAG(0x29)
			Insert DBTAG(0x31)
			Insert DBTAG(0x39)
			Insert DBTAG(0x41)
			Insert DBTAG(0x49)
			Insert DBTAG(0x51)
			Insert DBTAG(0x59)
			Insert DBTAG(0x61)
			Insert DBTAG(0x69)

Figure 4-8 Setting Measurement Conditions and Starting Measurement (Insertion of DBTAG Instruction)

[Note] A debugging instruction cannot be automatically inserted when the compiler does not support this function.

Compiler supporting this function: CC-RH V1.06.00 or later

 Writing a debugging instruction (DBTAG) to the source code Sample code of the DBTAG instructions supported by the CAN communication time measurement solution is shown in Figure 4-9.

shown in Figure 4-9.	
dbgtag(0x21)	1
dbgtag(0x29)	
dbgtag(0x31)	
dbgtag(0x39)	
dbgtag(0x41)	
dbgtag(0x49)	
dbgtag(0x51)	
dbgtag(0x59)	
dbgtag(0x61)	
dbgtag(0x69)	

Figure 4-9 Sample Code of DBTAG Instructions





Figure 4-10 Setting Measurement Conditions and Starting Measurement (Sample Code of DBTAG Instruction)



- (2) Selecting a solution
- 1. Select the [View] menu and click on [Solution List].

Figure 4-11 Setting Measurement Conditions and Starting Measurement (Display of Solution List)

2. Click on CAN (surrounded by a blue line in Figure 4-12) to select the CAN communication time measurement solution.



Figure 4-12 Setting Measurement Conditions and Starting Measurement (Solution List)

3. After step 2, the [Measuring CAN Bus Reception Processing Times] panel appears.

Figure 4-13 Setting Measurement Conditions and Starting Measurement ([Measuring CAN Bus Reception Processing Times] Panel)



- (3) Setting measurement conditions
- 1. Click on the [Set Condition] menu in the [Measuring CAN Bus Reception Processing Times] panel.

Measuring CA	N Bus Reception Processing
🖸 🖸 🔘	Set Condition - Delete Co
Measurement C	
Start Condition Condition Type	

Figure 4-14 Setting Measurement Conditions and Starting Measurement (Setting Measurement Conditions)

2. Set detection of a CAN frame as the measurement range start condition.

Setting example:

ch0, standard format, baud rate: 500K bps, sampling point: 80%, ID: 0x135h data length: 8 bytes, data: 0x01, 0x02, 0x03, 0x04, 0x05, 0x06, 0x07, 0x08

no mask, detection times: 1

Condition type:	Detect CAN Frame	-	<u>C</u> hannel:	ch0	-	
Frame format:	Standard	-	Baud rate:	500K bps	•	
			Sampling point:	80	•	%
<u>I</u> D:	HEN 135	-	<u>M</u> ask:	HEX 7FF	-	
<u>D</u> ata:	HEX 0102030405060708	-	<u>M</u> ask:	HEN FFFFFFFFFFFFFFFF	-	
Data <u>L</u> ength:	8 bytes	-	Detection times:	1	•	
			Waveform detection:	Rising edge	-	
condition ty	pe]		• [Ma	sk]		
- Select de	tection of a CAN frame.		- {	Set the mask value for the	ID and d	ata

- [ID], [Data], [Data Length]
 - Set the ID, data, and data length to be detected.
 - For data arrangement of the ID, see Figure 4-16.
 - For data arrangement of the data, see Figure 4-17.
- [Channel]
 - Select the channel to be used.
 ch0: Connect pin 4 of the E2 expansion interface.
 ch1: Connect pin 8 of the E2 expansion interface.
- [Baud rate]
 - Select the baud rate of communication.

- 0: Masked
- 1: Not masked

(The bit arrangement is the same as that for the ID and data.)

- [Detection times]
 - Set the number of times the CAN bus communication settings (ID, data, and data length) should be detected. When the condition has been satisfied for the number of times set as the detection times, the measurement range start condition is satisfied and time measurement is started.

Figure 4-15 Setting Measurement Conditions and Starting Measurement (Example: CAN Frame Detection is Set as the Start Condition)





Figure 4-16 Setting Measurement Conditions and Starting Measurement (Data Arrangement of ID/ID Mask of CAN Frame)



Figure 4-17 Setting Measurement Conditions and Starting Measurement (Data Arrangement of Data/Data Mask of CAN Frame)



3. Set detection of DBTAG as the measurement range end condition.

Setting example:

DBTAG value: 0x21

Conditon type:	Detection of DBTAG		 <u>D</u>BTAG value: 	0x21	-
<u>C</u> hannel:	ch0	,	Detected <u>w</u> aveform:	Rising edge	•
Timeout setting					
Detect <u>t</u> imeout:	No	Time <u>o</u> ut period:		-	ns
					1
-	ment range end cond detection of DBTAG. setting]	-	-	TAG value] Set the DBTAG measurement ra	value as the ange end condition.

Detection is Set as the End Condition)



4. Start time measurement.

Click on the button located in the [Measuring CAN Bus Reception Processing Times] panel shown in Figure 4-19 to run the user program and start measuring the time.

 When automatically inserting a debugging instruction (DBTAG) from the Editor panel See a) below.
 When writing a debugging instruction (DBTAG) to the source code See b) below.
a) Run the user program and start measuring the time (with build).
Measuring CAN Bus Reception Processing Times
Set Condition - Delete Condition - X
Start measurement of the CAN bus reception processing time without rebuilding to insert DBTAG.
Before starting measurement, execute "Rebuild & Download" for inserting the DBTAG instruction and a reset.
b) Run the user program and start measuring the time (without build).
Measuring CAN Bus Reception Processing Times
Set Condition ▼ Delete Condition ▼ ×
Mi Start measuring the CAN bus reception processing time.
"Rebuild & Download" for inserting the DBTAG instruction is not necessary.
Figure 4-19 Setting Measurement Conditions and Starting Measurement (Start of Measurement)

Figure 4-19 Setting Measurement Conditions and Starting Measurement (Start of Measurement

5. Stop time measurement.

Time measurement stops when the user program is halted.



4.3 Referencing the Time Measurement Results

(1) Display of Min/Max/Ave/Count values of time measurement results

Measuring CAN Bus Reception Processing Times	\mathbf{X}
🛐 🔯 🔲 Set Condition 🔹 Delete Condition 🔹 🔀	
Measurement Condition 1 Start Condition Condition Type: Detect CAN Frame Channel: ch0 Format: Standard Baud Rate: 500K bps Sample Point Ratio: 50% ID: 0x000, Mask: 0x000 Data: 0x0000000000000, Mask: 0x000000 Detection Times: 1	* E
End Condition Condition Type: Detection of DBTAG	
Maintain the DBTAG build option for subsequent measurements	
Measurement Results(1) 2017/07/13 16:55:20 [Min]: 333ns [Max]: 591ns [Ave]: 445ns [Count]: 1000	
<	- F
Min The minimum value of the time measurement between two points is shown in na Max The maximum value of the time measurement between two points is shown in na	
Ave The average value of the time measurement between two points is shown in nan	
Count The number of times measurement was carried out is shown.	
or the timing to measure the section time, see Figure 2-1.	
ure 4-20 Displaying the Time Measurement Results (Display of Min/Max/A	ve/Count Val



- (2) Referencing the CAN bus communication history and execution history of the DBTAG instruction
- 1. Click on the 🖾 button in the [Measuring CAN Bus Reception Processing Times] panel and specify the file format (CSV format or Microsoft Office Excel book (*.xls) format) for recording the results.





2. Reference the file that was saved in step 1.

Example: Incrementation from CAN bus communication ID=0, incrementation from DATA=0, DBTAG instruction (0x21)

34 [Time]	[Type]	[Contents]
35 0h 00m 00s 000ms 000us 000	CAN	ID=0x000 DLC=0x8 DATA=0x000000000000000 Ack=0
36 0h 00m 00s 000ms 247us 592	SWTrace	DBTAG 0x021
37 0h 00m 00s 000ms 254us 500	SWTrace	DBTAG 0x021
38 0h 00m 00s 000ms 260us 108	CAN	ID=0x001 DLC=0x8 DATA=0x01000000000000 Ack=0
39 0h 00m 00s 000ms 505us 867	SWTrace	DBTAG 0x021
40 0h 00m 00s 000ms 512us 775	SWTrace	DBTAG 0x021
41 0h 00m 00s 000ms 518us 217	CAN	ID=0x002 DLC=0x8 DATA=0x02000000000000 Ack=0
42 0h 00m 00s 000ms 761us 867	SWTrace	DBTAG 0x021
43 0h 00m 00s 000ms 768us 775	SWTrace	DBTAG 0x021
44 0h 00m 00s 000ms 774us 333	CAN	ID=0x003 DLC=0x8 DATA=0x03000000000000 Ack=0
45 0h 00m 00s 001ms 020us 050		
īme] column	SWTrace	DBTAG 0x021
Time] column he elapsed time is shown.		DBTAG 0x021

Figure 4-22 Referencing the Execution History (Reference to CSV File)



5. Usage Notes

5.1 Combined Use with Other Functions

- (1) When this solution is used, the following functions cannot be used.
 - Hot plug-in connection
 - While the user program is running, the only function that can be manipulated from the emulator debugger is a forcible break. The other functions are not usable.



5.2 Notes on Breaks

- (1) Immediately after the program starts running, there is a period in which breaks cannot be detected.
 When the CPU is operating in the low-speed OCO mode
 - Breaks are not detectable during the 100-µsec period after a program has started to run. — Other than above
 - Breaks are not detectable during the 10-µsec period after a program has started to run.
- (2) After a break event occurs, there is a delay before the actual break occurs. For the delay time, see Table 5-1.

Table 5-1Relationship between the Break Type Supported by the CAN Communication Time
Measurement Solution and the Delay Time

No.	Break Type	Device Type	Delay Time
1	Timeout break during the period from a	Device that supports deep stop	Table 5-2,
	CAN frame to software tracing	mode	Table 5-3
2		Device that does not support deep	Table 5-4,
		stop mode	Table 5-5
3	Timeout break during the period from trigger	Device that supports deep stop	Table 5-2,
	input to software tracing	mode	Table 5-3
4		Device that does not support deep	Table 5-4,
		stop mode	Table 5-5
5	Timeout break during the period from a		Table 5-6,
	CAN frame to trigger input		Table 5-7
6	Timeout break during the period from trigger	—	Table 5-6,
	input to trigger input		Table 5-7

Table 5-2Delay Time until Break Occurrence in LPD 4-pin Mode
(with software tracing, when the device supports deep stop mode)

Debug I/F	LPD 4-pin	LPD 4-pin	LPD 4-pin
Delay Time	16.5 [MHz]	11 [MHz]	5.5 [MHz]
Delay time	5 to 8 [µs]	6 to 10 [μs]	11 to 16 [μs]

Table 5-3Delay Time until Break Occurrence in LPD 1-pin Mode
(with software tracing, when the device supports deep stop mode)

Debug I/F	LPD 1-pin	LPD 1-pin	LPD 1-pin
Delay Time	2 [MHz]	1 [MHz]	500 [kHz]
Delay time	26 to 37 [µs]	51 to 70 [μs]	99 to 135 [µs]

Table 5-4Delay Time until Break Occurrence in LPD 4-pin Mode
(with software tracing, when the device does not support deep stop mode)

Debug I/F	LPD 4-pin	LPD 4-pin	LPD 4-pin	LPD 4-pin
Delay Time	33 [MHz]	16.5 [MHz]	11 [MHz]	5.5 [MHz]
Delay time	8 to 11 [μs]	10 to 15 [μs]	13 to 19 [μs]	22 to 31 [µs]



Table 5-5Delay Time until Break Occurrence in LPD 1-pin Mode
(with software tracing, when the device does not support deep stop mode)

Debug I/F	LPD 1-pin	LPD 1-pin	LPD 1-pin
Delay Time	2 [MHz]	1 [MHz]	500 [kHz]
Delay time	51 to 70 [μs]	99 to 135 [μs]	196 to 266 [µs]

Table 5-6 Delay Time until Break Occurrence in LPD 4-pin Mode (without software tracing)

Debug I/F	LPD 4-pin	LPD 4-pin	LPD 4-pin	LPD 4-pin
Delay Time	33 [MHz]	16.5 [MHz]	11 [MHz]	5.5 [MHz]
Delay time	3 to 7 [μs]	4 to 12 [µs]	6 to 16 [μs]	10 to 29 [μs]

Table 5-7 Delay Time until Break Occurrence in LPD 1-pin Mode (without software tracing)

Debug I/F	LPD 1-pin	LPD 1-pin	LPD 1-pin
Delay Time	2 [MHz]	1 [MHz]	500 [kHz]
Delay time	25 to 75 [μs]	50 to 147 [μs]	98 to 290 [µs]



5.3 Notes on Software Tracing

(1) Execution interval of software trace instructions

The execution interval of software trace instructions is restricted.

The time shown in Table 5-8 should be ensured as the execution interval of software trace instructions. If the required time is not satisfied, the following problems will arise.

- Time measurement by this solution cannot be performed correctly.
- A loss occurs in software tracing and data cannot be recorded.

Debug I/F							
Instruction	LPD 4-pin	LPD 4-pin	LPD 4-pin	LPD 4-pin	LPD 1-pin	LPD 1-pin	LPD 1-pin
Туре	33 [MHz]	16.5 [MHz]	11 [MHz]	5.5 [MHz]	2 [MHz]	1 [MHz]	500 [kHz]
DBTAG (without PC)	0.1 [μs]	0.2 [μs]	0.3 [μs]	0.6 [μs]	1.6 [μs]	3.2 [μs]	6.4 [μs]
DBTAG (with PC)	2.3 [μs]	4.7 [μs]	7 [μs]	13.9 [μs]	38 [µs]	76 [μs]	152 [μs]

(2) Software tracing function when the 1-pin LPD interface is selected When the 1-pin LPD is selected and a break is generated as a forced break, a trace-full break from the E2 storage, or a break due to the input of an external trigger, software tracing cannot be used when execution of the program is subsequently resumed. To proceed with software tracing again, re-connect the emulator to the debugger.

(3) Cautionary point regarding trace data acquired by software tracing When a break is generated as a forced break, a trace-full break from the E2 storage, or a break due to the input of an external trigger, information from a debugging instruction that was executed immediately before the break will not be stored in the E2 storage.

When a debugging instruction is executed during single-stepped execution and a software break or hardware break is specified and executed by the debugging instruction, software trace data are not output through the LPD interface.

When trace acquisition is stopped due to a break generated by a software break, hardware break, event break, or full break of internal trace memory, the history of execution from a DBCP instruction executed in the debugging area is stored as the final trace data in the E2 storage and internal trace memory after the break in execution.

(4) Automatic insertion of a debugging instruction (DBTAG) from the emulator debugger

If the compiler does not support this function, a debugging instruction cannot be automatically inserted. Compiler supporting this function: CC-RH V1.06.00 or later



5.4 Notes on External Trigger Function

(1) Delay time of external trigger output

After an event for external trigger output is detected, there is a delay before the output of the external trigger signal is started.

The delay time is explained in Table 5-9 to Table 5-13.

Table 5-9Delay Time of Trigger Output at Detection of Software Trace (DBTAG Instruction) in LPD
4-pin Mode

Debug I/F	LPD 4-pin	LPD 4-pin	LPD 4-pin	LPD 4-pin
Delay Time	33 [MHz]	16.5 [MHz]	11 [MHz]	5.5 [MHz]
Delay time	(CPU clock \times 3)			
	+ (0.05 to 0.1)	+ (0.07 to 1.9)	+ (0.1 to 2.7) [µs]	+ (0.1 to 5.3) [µs]
	[µS]	[µS]		

Table 5-10Delay Time of Trigger Output at Detection of Software Trace (DBTAG Instruction) in
LPD 1-pin Mode

Debug I/F	LPD 1-pin	LPD 1-pin	LPD 1-pin
Delay Time	2 [MHz]	1 [MHz]	500 [kHz]
Delay time	(CPU clock \times 3)	(CPU clock \times 3)	(CPU clock \times 3)
	+ (0.5 to 12) [µs]	+ (0.9 to 23) [µs]	+ (1.8 to 45) [µs]

Table 5-11 Delay Time of Trigger Output at Detection of CAN Frame

Delay time	8 to 17 [ns]

Table 5-12 Delay Time of Trigger Output at Detection of Timeout in LPD 4-pin Mode

Debug I/F	LPD 4-pin	LPD 4-pin	LPD 4-pin	LPD 4-pin
Delay Time	33 [MHz]	16.5 [MHz]	11 [MHz]	5.5 [MHz]
Delay time	(CPU clock × 3) + (0.05 to 0.1) [μs]	(CPU clock × 3) + (0.07 to 1.9) [μs]	(CPU clock × 3) + (0.1 to 2.7) [μs]	(CPU clock × 3) + (0.2 to 5.3) [μs]

Table 5-13 Delay Time of Trigger Output at Detection of Timeout in LPD 1-pin Mode

Debug I/F	LPD 1-pin	LPD 1-pin	LPD 1-pin	
Delay Time	2 [MHz]	1 [MHz]	500 [kHz]	
Delay time	(CPU clock \times 3)	(CPU clock \times 3)	(CPU clock \times 3)	
	+ (0.5 to 12) [µs]	+ (0.9 to 23) [µs]	+ (1.8 to 45) [µs]	

(2) Setting of external trigger output

This solution cannot be used together with the external trigger input/output function that is provided as a basic function of the emulator debugger. While measuring CAN bus reception processing times, only the external trigger setting that was set by the CAN communication time measurement solution will be enabled.



5.5 Note on CAN Bus Monitoring

(1) Setup

When using this solution, connect the CAN receive data input pins of the RH850 to the E2 emulator with a test lead. If the attached test lead cannot be used for connection, separately prepare a connectable cable.

For the setup method, see "3.2 Setting the Hardware Environment".



5.6 Notes on Time Measurement Function

(1) Measurement error in time measurement function

There is a measurement error in the time measurement function. The measurement error is explained for each time

measurement item in Table 5-14 to Table 5-16.

Table 5-14Error When Measuring the Time from Receiving CAN Frame or Trigger Input to Software
Tracing in LPD 4-pin Mode

Debug I/F				
Measure-	LPD 4-pin	LPD 4-pin	LPD 4-pin	LPD 4-pin
ment Error	33 [MHz]	16.5 [MHz]	11 [MHz]	5.5 [MHz]
Measurement error	+(CPU clock \times 3)			
	+ (0 to 0.06) [μs]	+ (0 to 0.1) [μs]	+ (0 to 0.15) [μs]	+ (0 to 0.25) [µs]

Table 5-15Error When Measuring the Time from Receiving CAN Frame or Trigger Input to Software
Tracing in LPD 1-pin Mode

Debug I/F			
Measure-	LPD 1-pin	LPD 1-pin	LPD 1-pin
ment Error	2 [MHz]	1 [MHz]	500 [kHz]
Measurement error	+(CPU clock \times 3)	+(CPU clock \times 3)	+(CPU clock \times 3)
	+ (0 to 0.6) [µs]	+ (0 to 1.1) [μs]	+ (0 to 2.3) [µs]

Table 5-16 Error When Measuring the Time from Receiving CAN Frame to Trigger Input

Measurement error	+17 to 34 [ns]
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- (2) Restriction for setting the measurement range start/end condition when measuring CAN bus reception processing times
- The following cannot be set as measurement condition 1 or 2.
 - CAN bus monitoring of the same channel
 - External trigger input of the same channel
- The same operation cannot be set in [Timeout action] of measurement condition 1 or 2.
- (3) When a break occurs while measuring the section time

After a start condition for time measurement is satisfied, if a break occurs before the end condition is satisfied, this will be excluded from time measurement.

(4) Stopping internal tracing on timeout detection

When [Output the software trace from the LPD] (see Figure 4-4) is selected, stopping internal tracing is not selectable as the action on timeout detection.

(5) Measurement range of the section time

There is a period in which the section time cannot be measured. When the software trace (DBTAG) instruction that was set as the end condition for measuring the section time is executed at the timing defined with td (CAN_int – CAN_EOF-Sample) in Figure 2-1, the measurement result of the section time becomes 0. Make adjustments so that no software trace instruction will be executed during the period of td (CAN_int – CAN_EOF-Sample). The maximum value of td (CAN_int – CAN_EOF-Sample) is the time for one bit of baud rate of CAN bus communication.



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Revision History

		Descript	ion
Rev.	Date	Page	Summary
1.00	Jul. 16, 2017		First edition issued

General Precautions in the Handling of Microprocessing Unit and Microcontroller Unit Products

The following usage notes are applicable to all Microprocessing unit and Microcontroller unit products from Renesas. For detailed usage notes on the products covered by this document, refer to the relevant sections of the document as well as any technical updates that have been issued for the products.

1. Handling of Unused Pins

Handle unused pins in accordance with the directions given under Handling of Unused Pins in the manual.

- The input pins of CMOS products are generally in the high-impedance state. In operation with an unused pin in the open-circuit state, extra electromagnetic noise is induced in the vicinity of LSI, an associated shoot-through current flows internally, and malfunctions occur due to the false recognition of the pin state as an input signal become possible. Unused pins should be handled as described under Handling of Unused Pins in the manual.
- 2. Processing at Power-on

The state of the product is undefined at the moment when power is supplied.

 The states of internal circuits in the LSI are indeterminate and the states of register settings and pins are undefined at the moment when power is supplied.

In a finished product where the reset signal is applied to the external reset pin, the states of pins are not guaranteed from the moment when power is supplied until the reset process is completed.

In a similar way, the states of pins in a product that is reset by an on-chip power-on reset function are not guaranteed from the moment when power is supplied until the power reaches the level at which resetting has been specified.

3. Prohibition of Access to Reserved Addresses

Access to reserved addresses is prohibited.

- The reserved addresses are provided for the possible future expansion of functions. Do not
 access these addresses; the correct operation of LSI is not guaranteed if they are accessed.
- 4. Clock Signals

After applying a reset, only release the reset line after the operating clock signal has become stable. When switching the clock signal during program execution, wait until the target clock signal has stabilized.

- When the clock signal is generated with an external resonator (or from an external oscillator) during a reset, ensure that the reset line is only released after full stabilization of the clock signal. Moreover, when switching to a clock signal produced with an external resonator (or by an external oscillator) while program execution is in progress, wait until the target clock signal is stable.
- 5. Differences between Products

Before changing from one product to another, i.e. to a product with a different part number, confirm that the change will not lead to problems.

 The characteristics of Microprocessing unit or Microcontroller unit products in the same group but having a different part number may differ in terms of the internal memory capacity, layout pattern, and other factors, which can affect the ranges of electrical characteristics, such as characteristic values, operating margins, immunity to noise, and amount of radiated noise. When changing to a product with a different part number, implement a system-evaluation test for the given product.

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